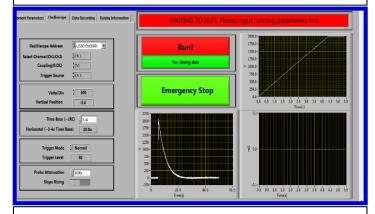
Capacitor Discharge Test System PK-CPR1701



This test system was inspired by the publication of Zhang et al "A Dielectric Polymer with High Electric Energy Density and Fast Discharge Speed". *Science* 313, 334 (2006)

Functions

- This unique test setup can be used to evaluate the discharging performance (speed and energy density) of new dielectric materials (100 pF) or packaged capacitors (100 μF) under high voltage.
- PE loop test provides incorrect energy density for capacitor application: the charges of the sample is discharged to power supply in a linear function (10-100 ms) and it significantly over estimate the energy density! In practical application, the discharging usually in nanosecond to millisecond and the discharge is exponential decay!
- It controls a high voltage power supply to charge the specimen to a pre-set voltage → disconnect the charged sample from the power supply → connect the charged sample to a load resistor (user selectable) with a HV MOSFET switch.
- The voltage across the load is recorded with an oscilloscope through a HV probe. Data are then transferred to the host computer, and discharged energy density is calculated automatically.
- Two Operation Modes:
 - Manual: the user control the charging relay and the discharging switch by pushing the buttons.
 - Auto: computer control everything and save test results.



LabView Control Program: Auto Mode

- Test controlled by the PK CapControl® LabView
- Set test voltage, charging current or voltage ramp rate, number of test cycles, data storage locations
- Control the HV amplifier, switch, and oscilloscope
- Automatically perform charge-discharge cycle lifetime test and save original charge/discharge data (voltage vs. time). A summary file is generated to save all the charge cycle, charging time, energy density, etc.





Capability

- 1. Voltage: 15 kV (relay and switch)
- 2. Sample capacitance: $< 100 \text{ pF to} > 100 \text{ }\mu\text{F}$
- 3. Discharge peak current:* < 10 A to > 5,000 A
- 4. Discharging load: < 1 Ω to > 100 M Ω
- 5. Discharging speed: high voltage MOSFET switch, rise time < 10 ns.
- Accuracy of charging current, voltage, and energy is determined by the capability of the power supply & sample capacitance.
- Temperature of capacitor and ambient may be recorded during lifetime test [Option].
 - * Certain models are subject to Export Control regulation.

Recent Publications with this test system:

Wang et al "Sandwich-structured polymer nanocomposites with high energy density and great charge–discharge efficiency at elevated temperatures" *Proceedings of the National Academy of Sciences*, 2016; DOI: 10.1073/pnas.1603792113

http://www.pnas.org/content/113/36/9995.abstract







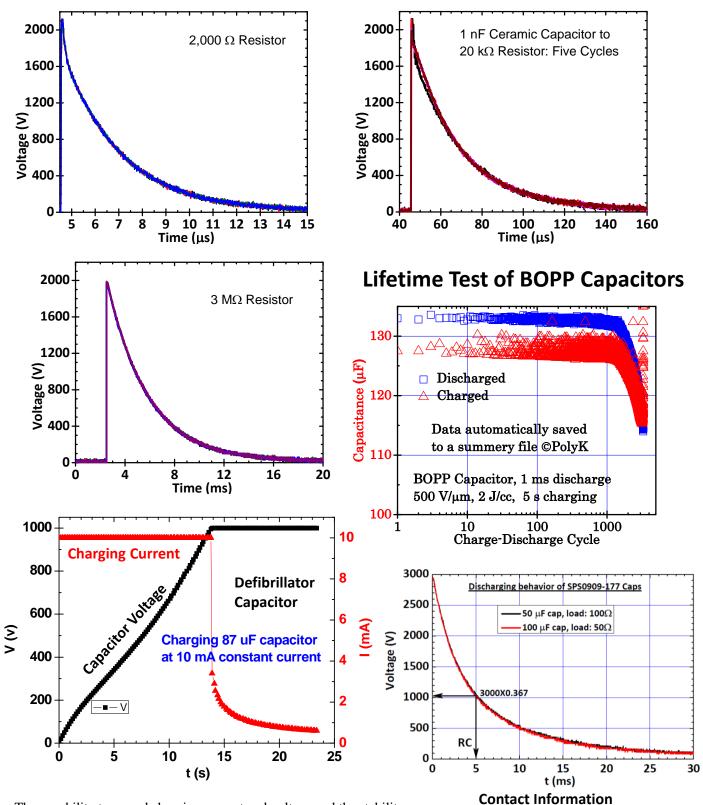


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Example Test Results PK-CPR1701



Discharge Speed Test: 1 nF Ceramic Capacitor



The capability to record charging current and voltage and the stability of the current are determined by the HV power supply or amplifier.

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